## Search Notes



App	licat	ion	Con	trol	No.

10089178 Examiner Applicant(s)/Patent Under Reexamination HIBINO ET AL.

50170

Art Unit

DEVONA E FAULK

2615

## SEARCHED

Class	Subclass	Date	Examiner
381	86	5/31/06	BTP
381	86,302,102-109	4/26/07	DEF
381	86,302,102-109	5/19/08	DEF
455	345,569.2	5/20/08	DEF
381	302,86	12/7/08	DEF
381	302,86,102-109,74,24,25	5/7/09	DEF
455	569.2,345	5/7/09	DEF
381	102-109,86,302,74	11/20/09	DEF
455	569.2,345	11/20/09	DEF

## **SEARCH NOTES**

Search Notes	Date	Examiner
Assignee/Inventor search	4/26/07	DEF
reviewed applicant's arguments, maintained rejection	10/18/07	DEF
additonal search	5/19/08	DEF
additional search	12/7/08	DEF
additional search	5/7/09	DEF
additional search	11/20/09	DEF

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/DEVONA E FAULK/ Primary Examiner.Art Unit 2614

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